


<b>Search Notes</b>  	<b>Application/Control No.</b>  10597852	<b>Applicant(s)/Patent Under Reexamination</b>  KEMPPAINEN ET AL.
	<b>Examiner</b>  Juan J Campos	<b>Art Unit</b>  3654

<b>SEARCHED</b>			
<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
242	541.5, 541.4, 541.3, 541.1, 54, 542.3, 542.2, 5471	05/07/2009	J.J.C

<b>SEARCH NOTES</b>		
<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
Consulted Examiner Sang Kim (search class 242).	05/06/2009	J.J.C

<b>INTERFERENCE SEARCH</b>			
<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>

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